

Search Notes

Application/Control No.

10/829,157

Examiner

David E. Bochna

Applicant(s)/Patent under
Reexamination

OHYA, HIROSHI

Art Unit

3679

SEARCHED

| Class | Subclass | Date | Examiner |
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| 285 | 3 | 10/27/2005 | DB |
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INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

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